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## What is Claimed is:

- 1. A method for fabricating arbitrary profiles comprising: creating a mask with a plurality of holes, providing a material having different transmission coefficient than the substrate and sufficient optical density range, onto the substrate through the holes of the mask.
- 2. The method of claim 1 wherein said creating of the mask comprises depositing a coating on a polished substrate, patterning that coating, and removing a section or all of the substrate.
- 3. The method of claim 2 wherein the polished substrate is silicon.
- 4. The method of claim 2 wherein the deposited coating is silicon nitride.
- 5. The method of claim 2 wherein said patterning includes photolithographic processes.
- 6. The method of claim 2 wherein said patterning includes laser ablation.
- 7. The method of claim 2 said removing includes etching.
- 8. The method of claim 7 wherein said etching includes using potassium hydroxide.
- 9. The method of claim 1, wherein said mounting includes providing a mask substrate between the mask and the substrate.

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- 10. The method of claim 1, wherein said mounting includes providing a machined metal spacer between the mask and the substrate.
  - 11. The method of claim 1, wherein the substrate is fused silica.
    - 12. The method of claim 1, wherein said providing includes evaporating a metal.
- 13. The method of claim 1, further comprising, after said providing, fabricating a plurality of lenses on the substrate.
  - 14. The method of claim 1, further comprising, before said providing, fabricating a plurality of lenses on the substrate.
- 15. The method of claim 1, wherein the substrate is reflective and the material is more absorbing than the substrate.
  - 16. The method of claim 1, wherein the substrate is transmissive and the material is more reflective than the substrate.
  - 17. The method of claim 1, further comprising spacing the mask from the substrate before said providing.
- 18. The method of claim 1, further comprising providing a phase controlling surface on the substrate.

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- 19. A device comprising an array of apodized apertures on a substrate.
- 20. The device of claim 18, wherein the array of apodized apertures are combined with a corresponding array of lenses.

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- 21. The device of claim 18, wherein the apodized apertures are on a fused silica substrate.
- 22. The device of claim 18, wherein the apodized apertures include a super-gaussian function.
  - 23. An element comprising a first portion controlling a phase of light incident thereon and a second portion on the first portion, having a different transmission coefficient than the first portion, the second portion controlling an irradiance of light incident thereon.
  - 24. The element of claim 23, wherein the second portion is directly on the first portion.
- 25. The element of claim 23, wherein the second portion is opposite a first portion on a substrate.